

Search Notes

Application/Control No.

10/535,257

Examiner

Trinh T. Nguyen

Applicant(s)/Patent under
Reexamination

OKAMOTO ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
updated	searches	1/16/2007	TTN
as on	search	↓	↓
note	5/2/06	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR